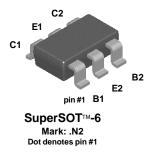


# **FMB200**



# **PNP Multi-Chip General Purpose Amplifier**

This device is designed for general purpose amplifier applications at collector currents to 300 mA. Sourced from Process 68.

## **Absolute Maximum Ratings\*** T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
$V_{CEO}$	Collector-Emitter Voltage	45	V
V <sub>CBO</sub>	Collector-Base Voltage	60	V
V <sub>EBO</sub>	Emitter-Base Voltage	6.0	V
Ic	Collector Current - Continuous	500	mA
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

<sup>\*</sup>These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

- 1) These ratings are based on a maximum junction temperature of 150 degrees C.
  2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- 3) All voltages (V) and currents (A) are negative polarity for PNP transistors.

# **Thermal Characteristics** $T_A = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Characteristic	Max	Units
		FMB200	
P <sub>D</sub>	Total Device Dissipation	700	mW
	Derate above 25°C	5.6	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	180	°C/W

# **PNP Multi-Chip General Purpose Amplifier**

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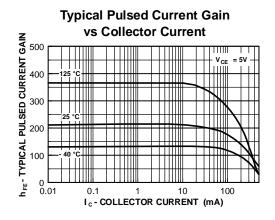
 $T_{\Lambda} = 25^{\circ}$ C unless otherwise noted

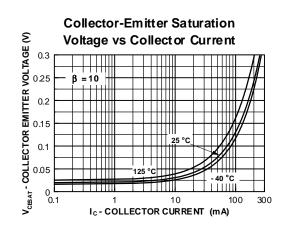
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
OFF CHAF	RACTERISTICS					
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	$I_C = 10 \mu\text{A},  I_B = 0$	60			V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage*	$I_C = 1.0 \text{ mA}, I_E = 0$	45			V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = 10 \mu\text{A},  I_C = 0$	6.0			V
I <sub>CBO</sub>	Collector Cutoff Current	$V_{CB} = 50 \text{ V}, I_{E} = 0$			50	nA
I <sub>CES</sub>	Collector Cutoff Current	$V_{CE} = 40 \text{ V}, I_{E} = 10$			50	nA
I <sub>EBO</sub>	Emitter Cutoff Current	$V_{EB} = 4.0 \text{ V}, I_{C} = 0$			50	nA
	Table 1	T			1	1
h <sub>FE</sub>	DC Current Gain	$I_C = 100 \mu A, V_{CE} = 1.0 V$	80		450	
h <sub>FE</sub>	DC Current Gain	$I_C = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$	100		450 350	
		$I_C = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_C = 150 \text{ mA}, V_{CE} = 5.0 \text{ V}^*$			450 350 0.2	V
	DC Current Gain  Collector-Emitter Saturation Voltage	$I_C = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$	100		350	V
V <sub>CE(sat)</sub>		$\begin{split} & I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ & I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ & I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ & I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ & I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \end{split}$	100		350 0.2	V
$\begin{array}{c} h_{FE} \\ \\ V_{CE(sat)} \\ \\ V_{BE(sat)} \end{array}$	Collector-Emitter Saturation Voltage	$\begin{split} &I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ &I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ &I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \end{split}$	100		350 0.2 0.4	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$\begin{split} & I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ & I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ & I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ & I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ & I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \end{split}$	100		350 0.2 0.4 0.85	V
V <sub>CE(sat)</sub> V <sub>BE(sat)</sub>	Collector-Emitter Saturation Voltage  Base-Emitter Saturation Voltage	$\begin{split} & I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ & I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ & I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ & I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ & I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \end{split}$	100	300	350 0.2 0.4 0.85	V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage  Base-Emitter Saturation Voltage  GNAL CHARACTERISTICS	$\begin{split} &I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ &I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ &I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ &I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ \end{split}$	100	300 4.5	350 0.2 0.4 0.85	V V V

<sup>\*</sup>Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%

NOTE: All voltages (V) and currents (A) are negative polarity for PNP transistors.

# **Typical Characteristics**

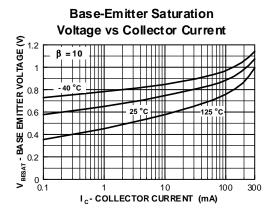


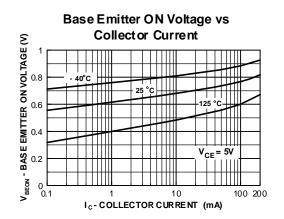


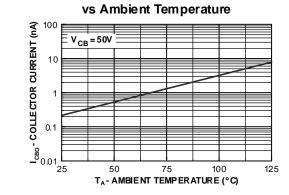
## **PNP Multi-Chip General Purpose Amplifier**

(continued)

## Typical Characteristics (continued)



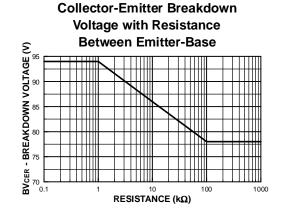


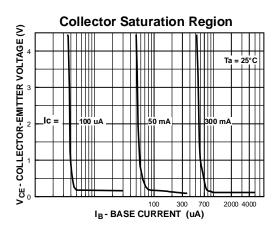


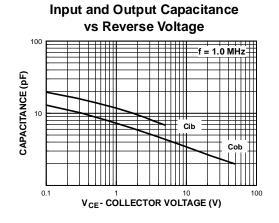
TA- AMBIENT TEMPERATURE (°C)

125

**Collector-Cutoff Current** 



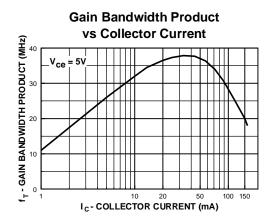


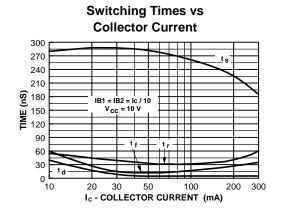


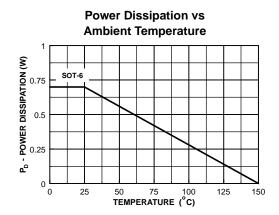
# **PNP Multi-Chip General Purpose Amplifier**

(continued)

## Typical Characteristics (continued)







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